

<b>Notice of References Cited</b>	Application/Control No. 10/811,050	Applicant(s)/Patent Under Reexamination MEEK ET AL.	
	Examiner Jeffrey S. Zweizig	Art Unit 2816	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,717,829	04-2004	Appeltans, Koen Emiel Jozef	363/59
	B	US-6,707,335	03-2004	Kawai et al.	327/536
	C	US-6,483,377	11-2002	White et al.	327/536
	D	US-6,208,196	03-2001	St. Pierre, Robert	327/536
	E	US-6,175,262	01-2001	Savelli et al.	327/536
	F	US-5,339,236	08-1994	Tamagawa, Akio	363/59
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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